Listing of the Claims

- 1. (Currently Amended) A magnetic localization device, comprising:
- a) a field generator (2) for generating a magnetic field;
- b) a field sensor (4)-for measuring the magnetic field;
- c) a reference sensor (3) for measuring the magnetic field at a known reference position;
- d) a control unit-(5), which is arranged for determining the position (\underline{x}') -of the field sensor (4)-relative to the field generator (2)-and thereby for compensating external field distortions by taking the reference sensor (3)-into consideration.
- 2. (Currently Amended) A localization device as claimed in claim 1, characterized in that wherein the spatial position of the field generator (2) is known.
- 3. (Currently Amended) A localization device (1) as claimed in claim 1, eharacterized in that-wherein the field generator (2) and/or the reference sensor (3) are fastened to the gantry (1) of a computer tomograph.
- 4. (Currently Amended) A localization device as claimed in claim 1, eharacterized in that wherein the control unit (5) contains a memory with a calibration function $(\underline{\delta}(\underline{x}, \Phi))$, which provides a correction shift ($\underline{\delta}$) for the uncorrected determined position (\underline{x}) of the field sensor (4) based on measured signals of the reference sensor (3) and the field sensor (4).
- 5. (Currently Amended) An examination device, comprising:
- an imaging device, in particular a computer tomograph-(1);
- a magnetic localization device (2, 3, 4, 5) as claimed in any one of the claims 1 to 4.

- 6. (Currently Amended) A method for position measurement with a magnetic localization device (2, 3, 4, 5), comprising the steps of:
- a) collecting the signals of a field sensor (4)-and/or a field generator-(2);
- b) collecting the signals of a magnetic reference sensor-(3), which is placed at a known spatial position relative to the field generator (2) or to the field sensor-(4);
- determining the position (\underline{x}') of the field sensor (4) relative to the field generator (2), where external field distortions are compensated by taking the signals of the reference sensor (3) into consideration.
- 7. (Currently Amended) A method as claimed in claim 6, characterized in that wherein a correction function $(\delta(\underline{x},\Phi))$ is determined, which indicates a correction shift (δ) for the uncorrected determined position of the field sensor (4)-in dependence on the signal of the reference sensor (3)-and the uncorrected determined position (\underline{x}) -of the field sensor (4).
- 8. (Currently Amended) A method as claimed in claim 7, characterized in that wherein the correction function $(\delta(\underline{x}, \Phi))$ for support points in a volume of interest (VOI) is empirically determined and extended by extrapolation or interpolation respectively on the whole volume (VOI).
- 9. (Currently Amended) A method as claimed in claim 6, characterized in that wherein a parameter (Φ) is determined from the signal of the reference sensor-(3), which parameter characterizes the external field distortion.
- 10. (Currently Amended) A method as claimed in claim 9, eharacterized in that wherein the parameter (Φ)-describes the angle of rotation of a computer tomograph (1) situated in the vicinity of the localization device.